Notice of References Cited Application/Control No. 10/676,198 Applicant(s)/Patent Under Reexamination TENCA ET AL. Examiner Uyen-Chau N. Le Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	А	US-5,477,526 A	12-1995	Inoue, Kazuo	369/275.4
	В	US-5,594,716 A	01-1997	Inoue, Kazuo	369/275.4
	С	US-4,728,193 A	03-1988	Bartelt et al.	356/509
	D	US-5,413,884 A	05-1995	Koch et al.	430/5
	E	US-6,437,324 B1	08-2002	Braun et al.	250/231.14
	F	US-6,384,501 B2	05-2002	Braun, Paul-Wilhelm	310/91
	G	US-5,036,192 A	07-1991	Ishizuka et al.	250/231.16
	Ξ	US-5,059,791 A	10-1991	Ishizuka et al.	250/231.17
	_	US-5,532,819 A	07-1996	Ishizuka et al.	250/237G
	J	US-5,665,965 A	09-1997	Durham, III, Ormonde G.	250/231.13
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
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	х							

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.